

Notice of References Cited

Application/Control No.

10/567,790

Applicant(s)/Patent Under
Reexamination
NAGOH ET AL.

Examiner

MICHAEL M. BERNSHTEYN

Art Unit

1796

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0263745	12-2005	Momoda et al.	252/586
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N	WO 9938924 A1	08-1999	World Intellect	CHEN et al.	
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	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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